Applicant(s)/Patent Under Reexamination Application/Control No. 10/053,074 KOSHIDA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Tae H Yoon 1714 **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2002/0002225 A1	01-2002	Reil, Frank	524/358
	В	US-			
	С	US-	-		
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	-	US-			
	J	US-			
	К	US-	,		
	L	US-			
-	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number	Date	Country	Name	Classification
		Country Code-Number-Kind Code	MM-YYYY			- Classification .
	N					
	0				·	
	Р	,				
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.